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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Application Number	10/077.910	_			
Filing Date	02/19/2002				
First Named Inventor	Patrick R. Connelly				
Art Unit	3762				
Examiner Name		_			
Attorney Docket Number	BTI-9				

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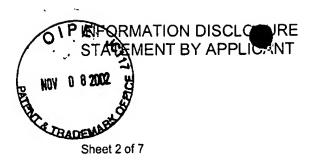
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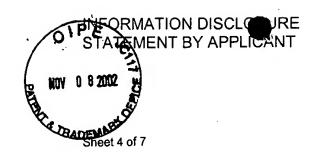
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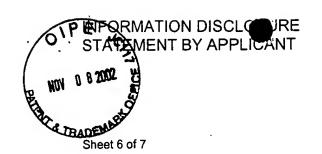
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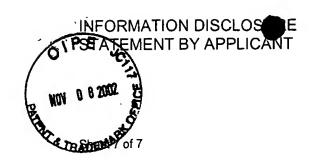
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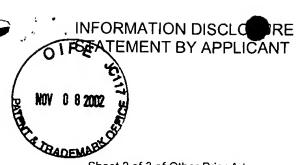
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